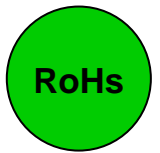


SPECIFICATION FOR APPROVAL



CUSTOMER _____

CUSTOMER'S DWG NO. _____

REVISION NO. _____

CUSTOMER'S PART NO. _____

TECSTAR'S PART NO. _____

TL201209-1R0K _____

QUANTITY _____

PCS _____

ITEM _____

DATE _____

SEP/03/2009 _____

	“√”	CUSTOMER'S SIGNATURE	NOTE
FULL APPROVED			
CONDITONAL APPROVED			
REJECTED			



TECSTAR TECHNOLOGY CO., LTD.

NO. 820-1 Kou Shih Rd. Yang Mei Chen

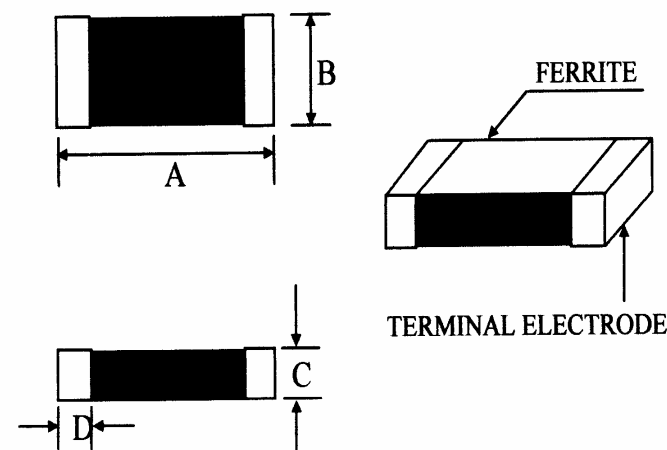
Taoyuan Hsien, Taiwan, R.O.C.

TEL : 886-3-4788701

FAX : 886-3-4788702

www tecstar.com.tw

SPECIFICATION FOR APPROVAL

CUSTOMER:		CUSTOMER'S P/N:	
VENDOR'S P/N:		TL201209-1R0K	
DIMENSION:(m/m) 		A	2.0 ± 0.2 m/m
		B	1.2 ± 0.2 m/m
		C	0.9 ± 0.2 m/m
		D	0.5 ± 0.3 m/m
		E	m/m
		F	m/m
		G	m/m
		H	m/m
		I	m/m
		J	m/m
		K	m/m
L	m/m		
M	m/m		
N	m/m		
O	m/m		
ELECTRICAL REQUIREMENTS		TEST INSTRUMENTS	
L	1.0 ± 10% μH	TEST FREQ.	10MHz/100mV
Q	45 MIN.	TEST FREQ.	10MHz/100mV
Srf	75 MHz MIN.	TEST FREQ.	MHz
Rdc	0.40 OHM. MAX.	TEST FREQ.	MHz
Idc	50 mA MAX.	TEST FREQ.	MHz
DRAWN BY		CHECKED BY	
Juli Wang		John Chuang	
APPROVED BY		Lionel Lin	

- HP 4338A MILLIOHMMETER
- HP 4195A NETWORK/SPECTRUM ANALYZER
- HP 4284A BIAS CURRENT SOURCE
- HP 4285A PRECISION LCR METER
- HP 4286A PRECISION LCR METER
- HP 4291B RF IMPEDANCE /MATERIAL ANALYZER
- HP 6632A DC POWER SUPPLY

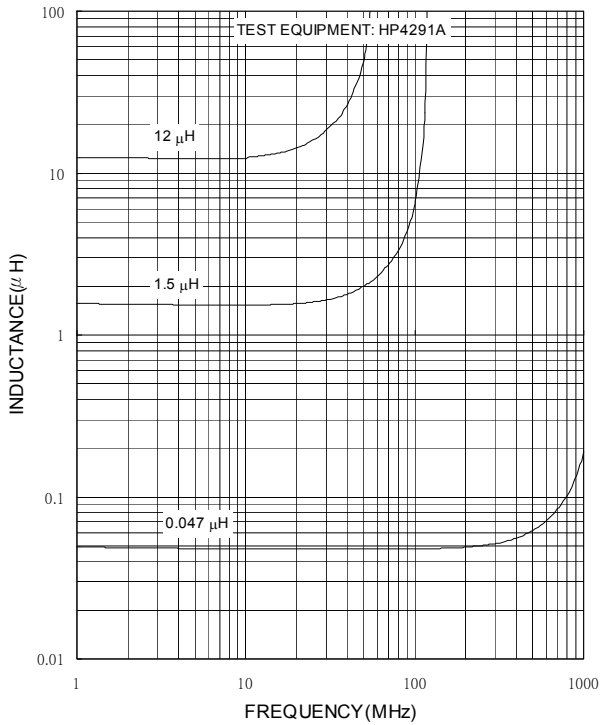
TEST DATA

CUSTOMER:							
CUSTOMER'S P/N:						SERIES NO:	TL3042
VENDOR'S P/N:		TL201209-1R0K				DATE:	03-SEP-2009
MEAS	A	B	C	D	L	Q	Rdc
ITEM	(m/m)	(m/m)	(m/m)	(m/m)	(μ H)		(Ω)
SPEC	2.0 ± 0.2	1.2 ± 0.2	0.9 ± 0.2	0.5 ± 0.3	$1.0 \pm 10\%$	45 MIN.	0.40 MAX.
TEST FREQ.					10 MHz	10 MHz	
1	2.02	1.23	0.88	0.52	0.99	62.3	0.183
2	2.01	1.25	0.90	0.50	1.01	68.5	0.175
3	2.05	1.22	0.89	0.48	1.03	64.4	0.174
4	2.03	1.21	0.92	0.52	1.03	70.5	0.177
5	2.02	1.24	0.91	0.50	0.96	67.3	0.188
6	2.00	1.23	0.89	0.51	1.02	68.1	0.178
7	2.04	1.23	0.90	0.49	0.98	67.7	0.181
8	2.01	1.21	0.88	0.53	1.03	69.0	0.186
9	2.00	1.22	0.89	0.52	1.01	69.2	0.186
10	2.03	1.24	0.88	0.53	0.97	64.4	0.176
AVG.	2.02	1.23	0.89	0.51	1.00	67.1	0.180
R	0.05	0.04	0.04	0.05	0.07	8.2	0.014
DRAWN BY			CHECKED BY			APPROVED BY	
Juli Wang			John Chuang			Lionel Lin	

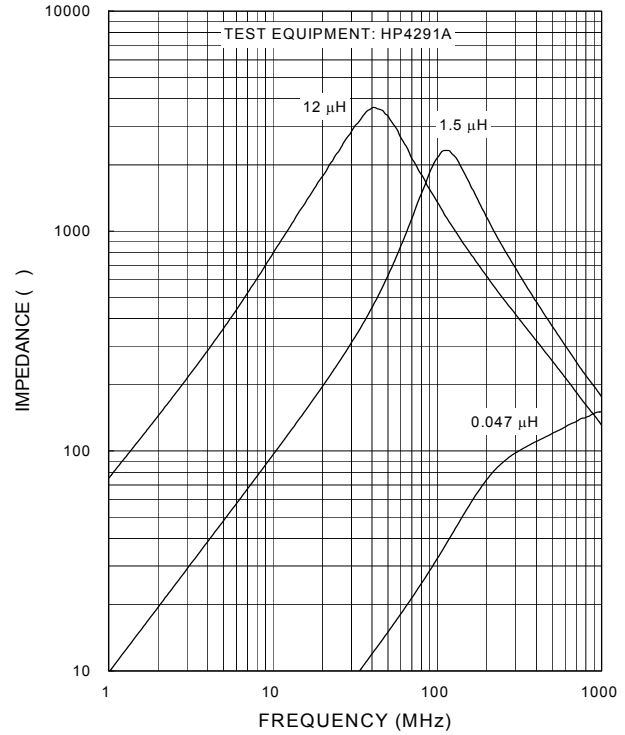
TYPICAL ELECTRICAL CHARACTERISTICS CURVE

TL2012 Type

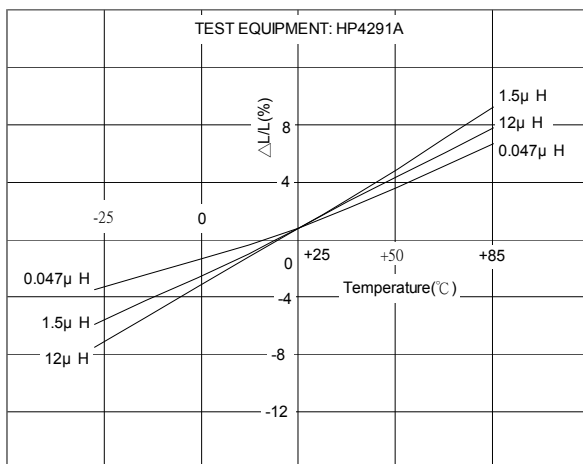
Inductance VS. Frequency



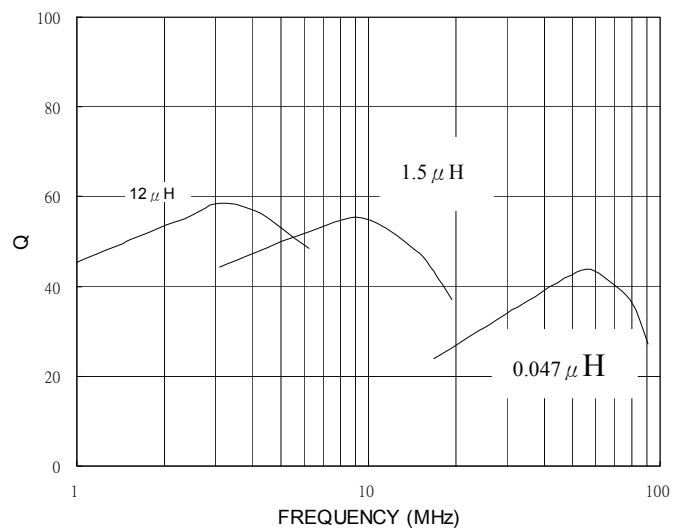
Impedance VS. Frequency



Inductance VS. Temperature



Q VS. Frequency



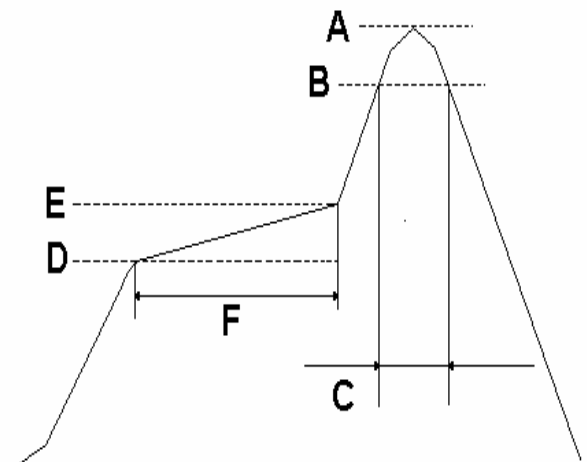
RELIABILITY TEST

Item	Performance	Test condition
Operating temperature range	-55 °C to + 125 °C	
Storage temperature and umidity ranges	40 °C MAX., 70% RH MAX.	
Soldering heat resistance	The chip shall not be cracks. More than 75% of terminal electrode shall be covered with solder.	Preheat: 150 °C, 60 seconds Solder temperature : 260 ± 5 °C Flux: Rosin Dip time: 10 ± 1 seconds
Solderability	More than 90% of the terminal electrode shall be covered with new solder.	Preheat: 150 °C, 60 seconds Solder temperature: 245 ± 5 °C Flux: Rosin Dip time: 4 ± 1 seconds

Recommended Soldering Conditions

(REFLOW TEMPERATURE PROFILE) Lead-Free

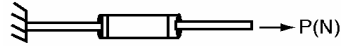
A	$260 \pm 5^{\circ}\text{C}$
B	$230 \pm 5^{\circ}\text{C}$
C	$30 \pm 10 \text{ sec}$
D	150°C
E	180°C
F	$90 \pm 30 \text{ sec}$



RELIABILITY TEST

Terminal strength

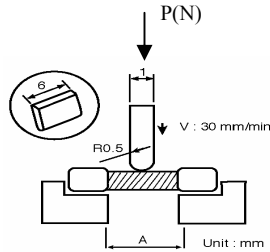
The terminal electrode and the body shall not be damaged by the forces applied on the right conditions.



Type	P (kgf)	Time (s)
T□100505	0.3	
T□160808	0.5	
T□201209	0.6	
T□201212	0.8	
T□321611	1.0	
T□322513	1.0	30 ± 5
T□451616	1.0	
T□453215	1.5	
TA3216M4	0.5	

Bending strength

The body shall not be damaged by the forces applied on the right conditions.



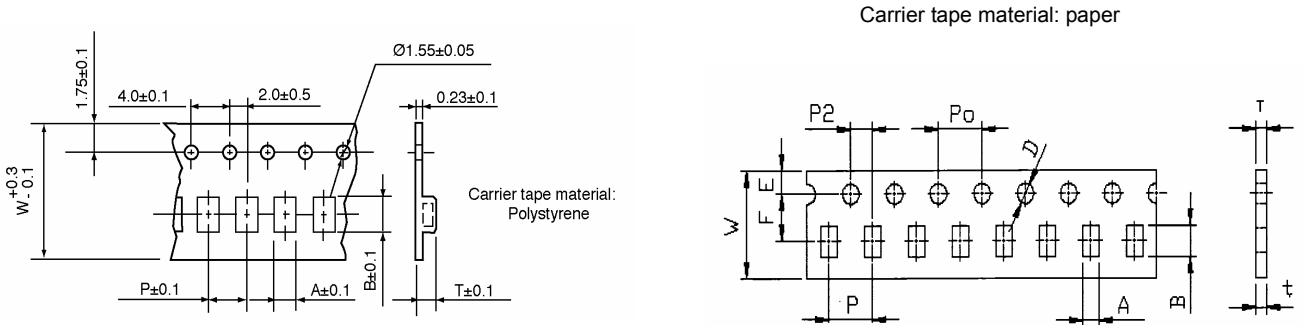
Type	A (mm)	P (kgf)
T□160808	1.0	0.5
T□201209	1.4	1.0
T□201212	1.4	1.2
T□321611	2.0	2.0
T□322513	2.0	2.5
T□451616	2.5	2.5
T□453215	2.7	2.5
TA3216M4	1.4	1.0

RELIABILITY TEST

Item	Performance	Test condition
High temperature resistance	Appearance : Ferrite shall not be damaged. Inductance : Within±10% of the initial value. Q: Within±30% of the initial value.	Temperature: 85±2°C Testing time: 1008±12 hours Measurement: After placing for 24 hours min
Humidity resistance	Appearance: Ferrite shall not be damaged. Inductance: Within±10% of the initial value Q: Within±30 % of the initial value.	Humidity: 90 to 95% RH Temperature: 40±2°C Testing time: 1008±12 hours Measurement: After placing for 24 hours min
Thermal Shock	Appearance: Cracking, chipping or any other defects harmful to the characteristics shall not be allowed. Inductance: Within±10% of the initial value Q: Within±30% of the initial value.	Temperature: -40°C, +85°C, kept stabilized for 30 minutes each Cycle: 100 cycles Measurement: After placing for 24 hours min
Low temperature storage life test	Appearance: Cracking, chipping or any other defects harmful to the characteristics shall not be allowed. Inductance: Within±10% of the initial value. Q: Within±30% of the initial value.	Temperature: -40±2°C Testing time: 1008±12 hours Measurement: After placing for 24 hours min

PACKAGING

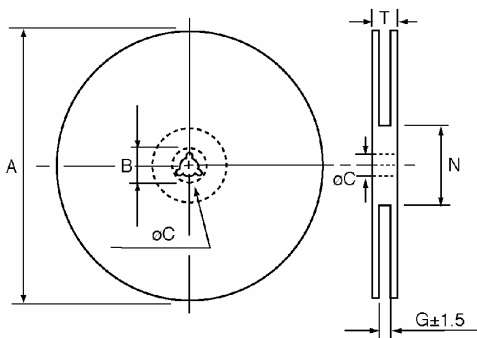
- Tape dimensions and packaging quantities



material: Paper (Dimensions in mm)						
TYPE	A	B	W	P	T	CHIPS / REEL
100505	0.62	1.12	8	2	0.60	10000
160808	1.10	1.90	8	4	0.95	4000
201209	1.50	2.30	8	4	0.95	4000
material: Polystyrene (Dimensions in mm)						
TYPE	A	B	W	P	T	CHIPS / REEL
160808	1.01	1.80	8	4	1.02	4000
201209	1.42	2.25	8	4	1.04	4000
201212	1.50	2.35	8	4	1.45	2000
321611	1.88	3.50	8	4	1.27	3000

- Reel dimensions

Material: Paper, Plastic



Dimensions in mm

TYPE	8mm	12mm
A	178±2	178±2
B	21.0±0.8	21.0±0.8
C	13.0±0.8	13.0±0.8
G	10.0	14.0
N	75	75
T	12.5	16.5

